## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | WISNIEWSKI ET AL. | Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,564,052 B1	05-2003	Kawano et al.	455/424
	В	US-6,658,250 B1	12-2003	Ganesan et al.	455/426.1
	O	US-2003/0007624 A1	01-2003	Handel et al.	379/220.01
	D	US-2002/0103010 A1	08-2002	Thomas et al.	455/560
	E	US-6,535,732 B1	03-2003	McIntosh et al.	455/445
	F	US-6,594,484 B1	07-2003	Hitchings, Jr., Sinclair H.	455/414.1
	G	US-6,917,818 B1	07-2005	Placho et al.	455/560
	Н	US-6,418,210 B1	07-2002	Sayko, Robert J.	379/142.15
	ı	US-2003/0179772 A1	09-2003	Niklasson, Sven	370/466
	J	US-2003/0162537 A1	08-2003	Hirsch, Lucian	455/423
	к	US-			
	L	US-			
	М	US-			,

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					•
	0					
	Р					
	ō.					
	R					
	S					
	Т	,		· · · · · · · · · · · · · · · · · · ·		

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	·
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.